IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Appl. No.

10/748.827

Confirmation No.

7166

First Inventor

Joonhyung Kwon

Filing Date

December 29, 2003

Art Unit

2856

Examiner

Larkin, Daniel Sean

Title:

Scanning Probe Microscope With Improved Probe Tip Mount

Drobo Tin Moun

Docket No.:

PSI004-1C US

Customer No.:

34036

Santa Clara, California March 31, 2005

Mail Stop AMENDMENT COMMISSIONER FOR PATENTS P.O. Box 1450 Alexandria, VA 22313-1450

RESPONSE TO NOTICE OF NON-COMPLIANT AMENDMENT

Dear Sir:

In an Office Action dated March 2, 2005, the Legal Instruments (LI) Examiner indicated that the Abstract must be presented on a separate sheet. Accordingly, a separate sheet containing the abstract is attached hereto. The LI Examiner further indicated that the abstract should show marked up changes relative to the immediate prior version. However, the immediate prior version has been completely re-written by the new abstract, because the new abstract is for this divisional application. Hence a marked up version of the abstract is not provided. Moreover, page 2 of the previously filed amendment is attached herewith, without the abstract at the bottom of this page.

The LI Examiner also indicated that a complete listing of all claims, including cancelled claims 1-20 needs to be presented in the section on claim amendments. Accordingly, attached hereto is a replacement set of pages 3-7 of the previously filed amendment, which have been revised on page 3 as requested.

Should there be any questions concerning this paper, the Examiner is invited to call the undersigned at (408) 982-8200, ext. 3.

CERTIFICATE OF FACSIMILE TRANSMISSION

I hereby certify that this correspondence is being facsimile transmitted to the U.S. Patent and Trademark Office to the central fax number 703-872-9306 on March 31, 2005.

Attorney for Applicant(s)

Morch 31, 2005

Date of Signature

Respectfully submitted,

Omkar K. Suryadevara Attorney for Applicant(s)

Reg. No. 36,320